

**SOT-23 Formed SMD Package**

**CMBD4150**

*SILICON PLANAR EPITAXIAL HIGH SPEED DIODE*

**Marking**

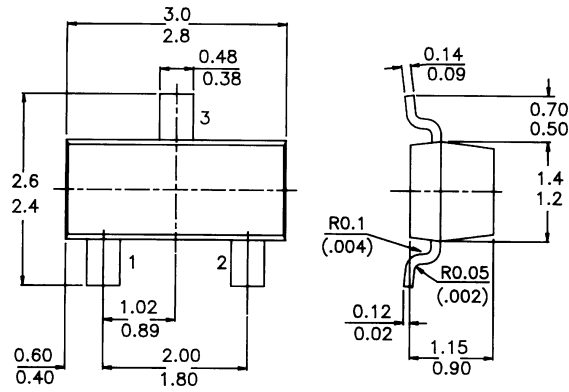
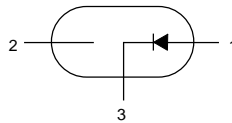
CMBD4150 = D18

**PACKAGE OUTLINE DETAILS**

ALL DIMENSIONS IN mm

**Pin configuration**

- 1 = ANODE
- 2 = NC
- 3 = CATHODE



**ABSOLUTE MAXIMUM RATINGS**

Continuous reverse voltage	$V_R$		50 V
Repetitive peak reverse voltage	$V_{RRM}$	max.	75 V
Repetitive peak forward current	$I_{FRM}$	max.	600 mA
Junction temperature	$T_j$	max.	150 °C
Peak forward surge current			
$T = 1 \mu\text{sec.}$	$I_{FSM}$	max.	4 A
$T = 1 \text{ sec.}$	$I_{FSM}$	max.	0.5 A
Reverse recovery time when switched from			
$I_F = 400 \text{ mA to } I_R = 400 \text{ mA}; R_L = 100 \Omega$			
measured at $I_R = 4 \text{ mA}$	$T_{rr}$	max.	6 ns

**RATINGS (at  $T_A = 25 \text{ }^\circ\text{C}$ , unless otherwise specified)**

Storage Temperature	$T_{stg}$		-55 to +150 °C
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**CMBD4150****THERMAL RESISTANCE**

From junction to ambient  $R_{th\ j-a}$  500 K/W

**CHARACTERISTICS (at  $T_A = 25\ ^\circ\text{C}$ , unless otherwise specified)**

Continuous reverse voltage	$V_R$	max.	50 V
Repetitive peak reverse voltage	$V_{RRM}$	max.	75 V
Forward current (d.c.)	$I_F$	max.	300 mA
Repetitive peak forward current	$I_{FRM}$	max.	600 mA
Non-repetitive peak forward current			
$T = 1\ \mu\text{sec}$	$I_{FSM}$	max.	4 A
$T = 1\ \text{sec}$	$I_{FSM}$	max.	0.5 A
Diode capacitance			
$V_R = 0; f = 1\ \text{MHz}$	$C_D$	max.	2.5 pF
Forward voltage			
$I_F = 1\ \text{mA}$	$V_F$	min.	540 mV
		max.	620 mV
$I_F = 10\ \text{mA}$	$V_F$	min.	660 mV
		max.	740 mV
$I_F = 50\ \text{mA}$	$V_F$	min.	760 mV
		max.	860 mV
$I_F = 100\ \text{mA}$	$V_F$	min.	820 mV
		max.	920 mV
$I_F = 200\ \text{mA}$	$V_F$	min.	870 mV
		max.	1 V
Reverse breakdown voltage			
$I_R = 100\ \text{mA}$	$V_{BR}$	min.	75 V
Reverse voltage leakage current			
$V_R = 50\ \text{V}$	$I_R$	max.	100 nA
Reverse current			
$V_R = 50\ \text{V}; T_j = 150\ ^\circ\text{C}$	$I_R$	max.	100 $\mu\text{A}$
Forward recovery voltage			
when switched to $I_F = 10\ \text{mA}; t_p = 20\ \text{nsec.}$	$V_{FR}$	max.	1.75 V
Reverse recovery time			
$I_F = I_R = 10 - 200\ \text{mAdc}, R_L = 100\ \Omega$	$t_{rr}$	max.	4 ns
$I_F = I_R = 200 - 400\ \text{mAdc}, R_L = 100\ \Omega$	$t_{rr}$	max.	6 ns

## Disclaimer

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